

L Number	Hits	Search Text	DB	Time stamp
1	8	transient adj fault adj protection	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:06
2	6	transient adj circuit adj protection	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:13
3	66	transient adj filtering	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:13
4	6	(transient adj filtering) same protection	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:17
5	0	non-transient adj fault adj conditions	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:17
6	0	(non-transient) adj fault adj conditions	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:18
7	1	nontransient adj fault adj conditions	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:19
8	84	transient adj fault adj conditions	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:19
9	0	(transient adj fault adj conditions) same filter	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:20
10	84	(transient adj fault adj conditions) same selectively	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:20
11	0	(transient adj fault adj conditions) same selectively	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:20
12	0	(transient adj fault adj conditions) same selectiv\$	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:21
13	26	(transient adj fault adj conditions) same circuit	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/06/29 13:27

14	561	(mems optomechanical)adj switches	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/06/29 13:44
15	0	((mems optomechanical)adj switches) same ((two dual multiple) adj actuating adj signals)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/06/29 14:02
16	5	((mems optomechanical)adj switches) same ((two dual multiple) adj signals)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/06/29 14:06
17	7	((mems optomechanical)adj switches) same (two dual multiple) adj (signals voltages)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/06/29 14:06